#1 IDS 6/30/03

INFORMATION CITED BY APPLICANT(S) THAT MAY BE MATERIAL TO THE PROSECUTION OF THE SUBJECT APPLICATION

Applicant:

R.B. Darling et al.

Attorney Docket No. UWOTL121266

Application No.: To Be Assigned

Group Art Unit: --

Filed:

Concurrently Herewith

Examiner: --

Title:

CHARGED PARTICLE BEAM DETECTION SYSTEM

U.S. PATENT DOCUMENTS

*Examiner Initials	Cite No.	Document No.	Kind Code	Date (mm/dd/yyyy)	Name
SES	บเ	4,290,012		09/15/1981	Berte et al.
BES	U2	4,973,840		11/27/1990	Srivastava
BES	U3	4,992,742		02/12/1991	Okuda et al.
BES	U4	5,198,676		03/30/1993	Benveniste et al.

FOREIGN PATENT DOCUMENTS

+12	0.4			Dublication Date		English	
*Examiner	Cite		Kind	Publication Date		Abstract	Translation
Initial	No.	Document No.	Code	(mm/dd/yyyy)	Country	Provided	Provided

NONE

OTHER INFORMATION (Including Author, Title, Date, Pertinent Pages, Etc.)

*Examiner	Cite
Initial	No.

NONE

Examiner

Date Considered

*Examiner: Initial if reference considered, whether or not citation is in conformance with M.P.E.P. § 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. GER:md

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#2 1DS 01/30/04

INFORMATION CITED BY APPLICANTS THAT MAY BE MATERIAL TO THE PROSECUTION OF THE SUBJECT APPLICATION

Applicants:

R.B. Darling et al.

Attorney Docket No. UWOTL121266

Application No.: 10/611,327

Group Art Unit: 2862

Filed:

June 30, 2003

Examiner: --

Title:

CHARGED PARTICLE BEAM DETECTION SYSTEM

U.S. PATENT DOCUMENTS

*Examiner Initials	Cite No.	Document No.	Kind Code	Date (mm/dd/yyyy)	Name
BES	U5	4,608,493	A	08/26/1986	Hayafuji
BES	U6	4,700,131	Α	10/13/1987	Miller
BES	U7	4,800,100	Α	01/24/1989	Herbots et al.

FOREIGN PATENT DOCUMENTS

*n ·	~			Publication Date		English
*Examiner	Cite		Kind	Publication Date		Abstract Translation
Initial	No.	Document No.	Code	(mm/dd/yyyy)	Country	Provided Provided

NONE

OTHER INFORMATION (Including Author, Title, Date, Pertinent Pages, Etc.)

*Examiner Cite Initial No.

NONE

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Date Considered

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Applicants:

R.B. Darling et al.

Attorney Docket No. UWOTL121266

Application No.: 10/611,327

Group Art Unit: 2862

Filed:

June 30, 2003

Confirmation No.: 3726

Title:

CHARGED PARTICLE BEAM DETECTION SYSTEM

U.S. PATENT DOCUMENTS

*Examiner Cite

Kind

Date

Initials

No.

Document No. Code (mm/dd/yyyy)

Name

NONE

FOREIGN PATENT DOCUMENTS

Examiner C	Cite No.	Document No.		Publication Date (mm/dd/yyyy)	Country	English Abstract Provided	Translation Provided
RES	F.1.	EP 0 762 472	Al	03/12/1997	EP		
BET	F2	WO 97/39474	Al	10/23/1997	wo		

OTHER INFORMATION

(Including Author, Title, Date, Pertinent Pages, Etc.)

*Examiner	Cite	
Initial	No.	
BES	01	Schuch, R.L. and J.G. Kelly, "A Compact Faraday Cup Array for Measurement of Current Distribution From Pulsed Electron Beams," Rev. Sci. Instrum. 43(8):1097-1099, August 1972.
BET	O2	Starke, T.P., "High Frequency Faraday Cup Array," Rev. Sci. Instrum. 51(11):1473-1477, November 1980.

Examiner

Date Considered

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